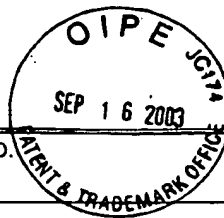




Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 217412US0		SERIAL NO. 10/025,762	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takashi MATSUO, et al.			
				FILING DATE December 26, 2001		GROUP 1714	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
COT	AO	JP 11-236323	08/31/99	JAPAN (w/English abstract)			XX
	AP	JP 11-507067	06/22/99	JAPAN (w/English abstract)			XX
	AQ	JP 11-29443	02/02/99	JAPAN (w/English abstract)			XX
	AR	JP 47-38974	10/02/72	JAPAN (w/English abstract)			XX
	AS	JP 9-100222	04/15/97	JAPAN (w/English abstract)			XX
	AT	JP 2002-47154	02/12/02	JAPAN (w/English abstract)			XX
	AU	JP 2001-335445	12/04/01	JAPAN (w/English abstract)			XX
COT	AV	JP 7-330552	12/19/95	JAPAN (w/English abstract)			XX
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
COT	AW	"Saishin Keshohin Kagaku (Modern Cosmetics Science)", first edition, pages 114-119, The Daily Pharmaceuticals, Inc., JAPAN (April 10, 1980).					
COT	AX	"Koshohin Kagagu (Perfumery & Cosmetics Science)", pages 382-392, Zaidan Hojin Japan Hair Science Association, JAPAN (December 1, 1976).					
	AY						
	AZ					<input checked="" type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered 5/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
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	AAP	JP 56-5410	01/20/81	JAPAN (w/English abstract)		XX	
	AAQ	JP 2001-199851	07/24/01	JAPAN (w/English abstract)		XX	
	AAR	JP 54-49340	04/18/79	JAPAN (w/English abstract)		XX	
	AAS	JP 5-67638	03/19/93	JAPAN (w/English abstract)		XX	
	AAT	JP 5-97638	04/20/93	JAPAN (w/English abstract)		XX	
	AAU	JP 7-316029	12/05/95	JAPAN (w/English abstract)		XX	
081	AAV	JP 10-316546	12/02/98	JAPAN (w/English abstract)		XX	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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SHEET 3 OF 3

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

217412US0

SERIAL NO.

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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Takashi MATSUO, et al.

FILING DATE

December 26, 2001

GROUP

1714

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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	BAB						
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FOREIGN PATENT DOCUMENTS

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CST	BAO	JP 5-97838	04/20/93	JAPAN (w/English abstract)		XX
	BAP	JP 7-89831	04/04/95	JAPAN (w/English abstract)		XX
	BAQ	JP 7-196935	08/01/95	JAPAN (w/English abstract)		XX
	BAR	JP 9-249537	09/22/97	JAPAN (w/English abstract)		XX
	BAS	JP 62-167504	07/23/87	JAPAN (w/English abstract)		XX
CST	BAT	JP 10-67624	03/10/98	JAPAN (w/English abstract)		XX
	BAU					
	BAV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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	BAX		
	BAY		
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☐ Additional References sheet(s) attached

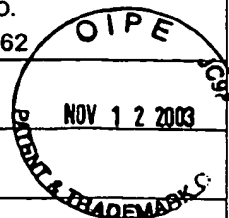
Examiner

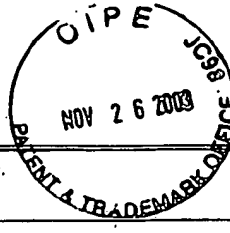
Date Considered

5/05

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FOREIGN PATENT DOCUMENTS							
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	AP	9-2924	01/07/97	Japan (w/English Abstract)			
	AQ	2000-16825	01/18/00	Japan (w/English Abstract)			
	AR	2000-309519	11/07/00	Japan (w/English Abstract)			
	AS	EP 1 031 343	08/30/90	Europe			xx
	AT	55-85512	06/27/80	Japan (w/English Abstract)			
	AU	2033939	05/29/80	Great Britain			
	AV	2-234971	09/18/90	Japan (w/English Abstract)			
	AW	9-67236	03/11/97	Japan (w/English Abstract)			
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,868,800	02/09/99	COTTERET et al. (corr. JP 7-316030)			
	AB	6,312,677	11/06/01	MILLEQUANT et al. (corr. JP 7-267836)			
	AC	5,534,036	07/09/96	JUNINO et al. (corr. JP 6-192055)			
	AD	5,518,506	05/21/96	COTTERET et al. (corr. JP 6-508376)			
	AE	5,628,991	05/13/97	SAMAIN et al. (corr. JP 5-246827)			
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	AO	5-279233	10/26/93	JAPAN (w/English abstract)			XX
	AP	7-316030	12/05/95	JAPAN (w/English abstract) (corr. U.S. 5,868,800)			XX
	AQ	7-267836	10/17/95	JAPAN (w/English abstract) (corr. U.S. 6,312,677)			XX
	AR	6-192055	07/12/94	JAPAN (w/English abstract) (corr. U.S. 5,534,036)			XX
	AS	6-508376	09/22/94	JAPAN (w/English abstract) (corr. U.S. 5,518,506)			XX
	AT	1-213220	08/28/89	JAPAN (w/English abstract)			XX
	AU	10-25230	01/27/98	JAPAN (w/English abstract)			XX
	AV	5-246827	09/24/93	JAPAN (w/English abstract) (corr. U.S. 5,628,991)			XX
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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